

<b>Notice of References Cited</b>		Application/Control No.	Applicant(s)/Patent Under Reexamination 10/643,669 TANNER ET AL.	
		Examiner	Art Unit Yoon-Young Kim	1723 Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-3,268,444	08-1966	RENN CHARLES E	210/679
*	B	US-3,333,703	08-1967	SCAVUZZO WILLIAM J; et. al.	210/232
*	C	US-3,670,892	06-1972	Baerg et al.	210/134
*	D	US-5,371,221	12-1994	Sipos et al.	544/275
*	E	US-6,177,319	01-2001	Chen, Shu-Jen	438/275
*	F	US-6,630,016 B2	10-2003	Koslows, Evan E.	95/285
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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	V	
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	X	

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